

## Single 16 and 8/Differential 8-Channel and 4-Channel CMOS Analog Multiplexers

The HI-506/HI-507 and HI-508/HI-509 monolithic CMOS multiplexers each include an array of sixteen and eight analog switches respectively, a digital decoder circuit for channel selection, voltage reference for logic thresholds, and an enable input for device selection when several multiplexers are present. The Dielectric Isolation (DI) process used in fabrication of these devices eliminates the problem of latchup. DI also offers much lower substrate leakage and parasitic capacitance than conventional junction isolated CMOS (see Application Notes AN520 and AN521).

The switching threshold for each digital input is established by an internal +5V reference, providing a guaranteed minimum 2.4V for logic "1" and maximum 0.8V for logic "0". This allows direct interface without pullup resistors to signals from most logic families: CMOS, TTL, DTL and some PMOS. For protection against transient overvoltage, the digital inputs include a series 200Ω resistor and diode clamp to each supply.

The HI-506 is a single 16-channel, the HI-507 is an 8-channel differential, the HI-508 is a single 8-channel and the HI-509 is a 4-channel differential multiplexer.

If input overvoltages are present, the HI-546/HI-547/HI-548/HI-549 multiplexers are recommended.

## Features

- Low ON Resistance ..... 180Ω
- Wide Analog Signal Range ..... ±15V
- TTL/CMOS Compatible
- Access Time ..... 250ns
- Maximum Power Supply ..... 44V
- Break-Before-Make Switching
- No Latch-Up
- Replaces DG506A/DG506AA and DG507A/DG507AA
- Replaces DG508A/DG508AA and DG509A/DG509AA

## Applications

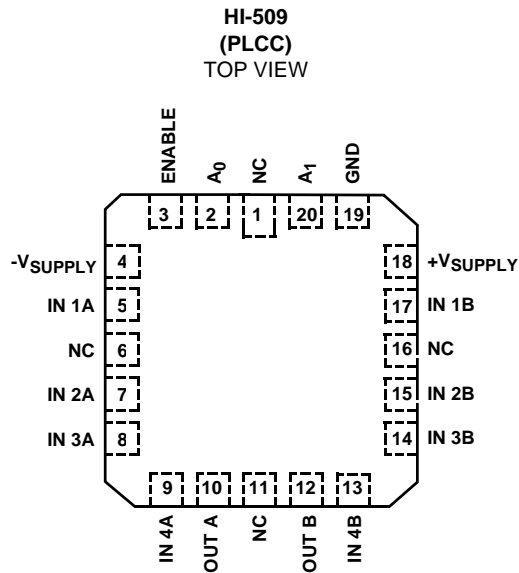
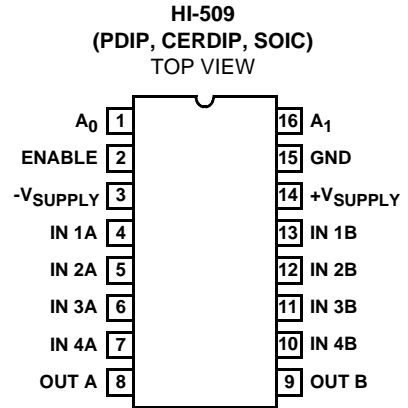
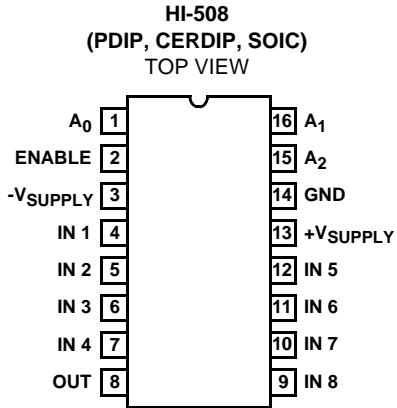
- Data Acquisition Systems
- Precision Instrumentation
- Demultiplexing
- Selector Switch

## Ordering Information

| PART NUMBER | TEMP. RANGE (°C) | PACKAGE      | PKG. DWG. # |
|-------------|------------------|--------------|-------------|
| HI1-0506-2  | -55 to 125       | 28 Ld CERDIP | F28.6       |
| HI1-0506-5  | 0 to 75          | 28 Ld CERDIP | F28.6       |
| HI3-0506-5  | 0 to 75          | 28 Ld PDIP   | E28.6       |
| HI4P0506-5  | 0 to 75          | 28 Ld PLCC   | N28.45      |
| HI9P0506-9  | -40 to 85        | 28 Ld SOIC   | M28.3       |
| HI1-0507-2  | -55 to 125       | 28 Ld CERDIP | F28.6       |
| HI3-0507-5  | 0 to 75          | 28 Ld PDIP   | E28.6       |
| HI1-0508-2  | -55 to 125       | 16 Ld CERDIP | F16.3       |
| HI1-0508-5  | 0 to 75          | 16 Ld CERDIP | F16.3       |
| HI3-0508-5  | 0 to 75          | 16 Ld PDIP   | E16.3       |
| HI9P0508-5  | 0 to 75          | 16 Ld SOIC   | M16.15      |
| HI9P0508-9  | -40 to 85        | 16 Ld SOIC   | M16.15      |
| HI1-0509-2  | -55 to 125       | 16 Ld CERDIP | F16.3       |
| HI1-0509-4  | -25 to 85        | 16 Ld CERDIP | F16.3       |
| HI1-0509-5  | 0 to 75          | 16 Ld CERDIP | F16.3       |
| HI3-0509-5  | 0 to 75          | 16 Ld PDIP   | E16.3       |
| HI4P0509-5  | 0 to 75          | 20 Ld PLCC   | N20.35      |
| HI9P0509-5  | 0 to 75          | 16 Ld SOIC   | M16.15      |



**Pinouts** (Continued)



Truth Tables

HI-506

| A <sub>3</sub> | A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL |
|----------------|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | X              | L  | None         |
| L              | L              | L              | L              | H  | 1            |
| L              | L              | L              | H              | H  | 2            |
| L              | L              | H              | L              | H  | 3            |
| L              | L              | H              | H              | H  | 4            |
| L              | H              | L              | L              | H  | 5            |
| L              | H              | L              | H              | H  | 6            |
| L              | H              | H              | L              | H  | 7            |
| L              | H              | H              | H              | H  | 8            |
| H              | L              | L              | L              | H  | 9            |
| H              | L              | L              | H              | H  | 10           |
| H              | L              | H              | L              | H  | 11           |
| H              | L              | H              | H              | H  | 12           |
| H              | H              | L              | L              | H  | 13           |
| H              | H              | L              | H              | H  | 14           |
| H              | H              | H              | L              | H  | 15           |
| H              | H              | H              | H              | H  | 16           |

HI-508

| A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL |
|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | L  | None         |
| L              | L              | L              | H  | 1            |
| L              | L              | H              | H  | 2            |
| L              | H              | L              | H  | 3            |
| L              | H              | H              | H  | 4            |
| H              | L              | L              | H  | 5            |
| H              | L              | H              | H  | 6            |
| H              | H              | L              | H  | 7            |
| H              | H              | H              | H  | 8            |

HI-509

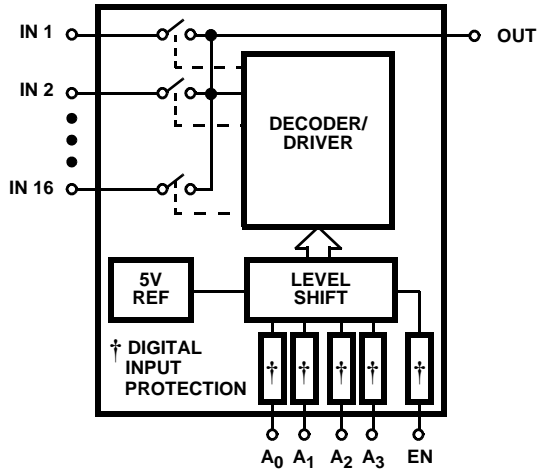
| A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL PAIR |
|----------------|----------------|----|-------------------|
| X              | X              | L  | None              |
| L              | L              | H  | 1                 |
| L              | H              | H  | 2                 |
| H              | L              | H  | 3                 |
| H              | H              | H  | 4                 |

HI-507

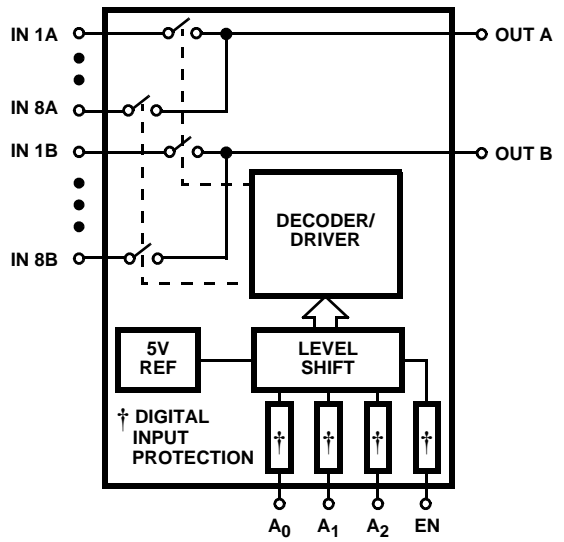
| A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | "ON" CHANNEL |
|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | L  | None         |
| L              | L              | L              | H  | 1            |
| L              | L              | H              | H  | 2            |
| L              | H              | L              | H  | 3            |
| L              | H              | H              | H  | 4            |
| H              | L              | L              | H  | 5            |
| H              | L              | H              | H  | 6            |
| H              | H              | L              | H  | 7            |
| H              | H              | H              | H  | 8            |

Functional Diagrams

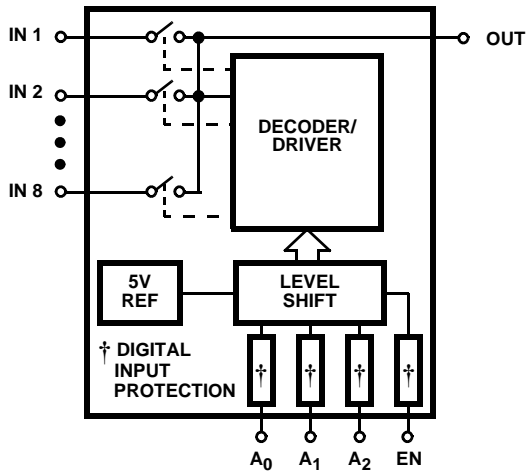
HI-506



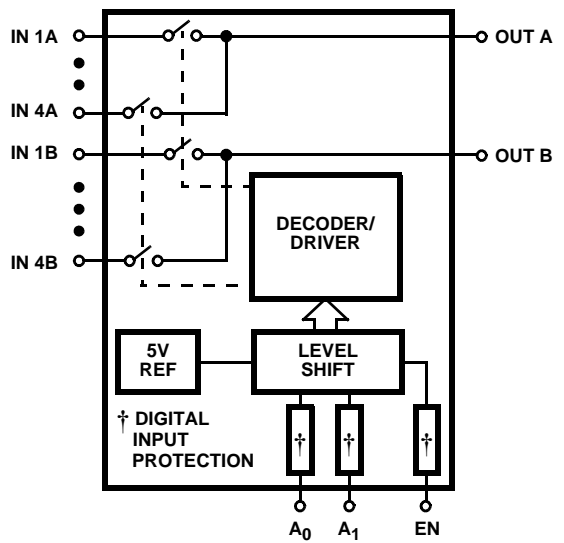
HI-507



HI-508

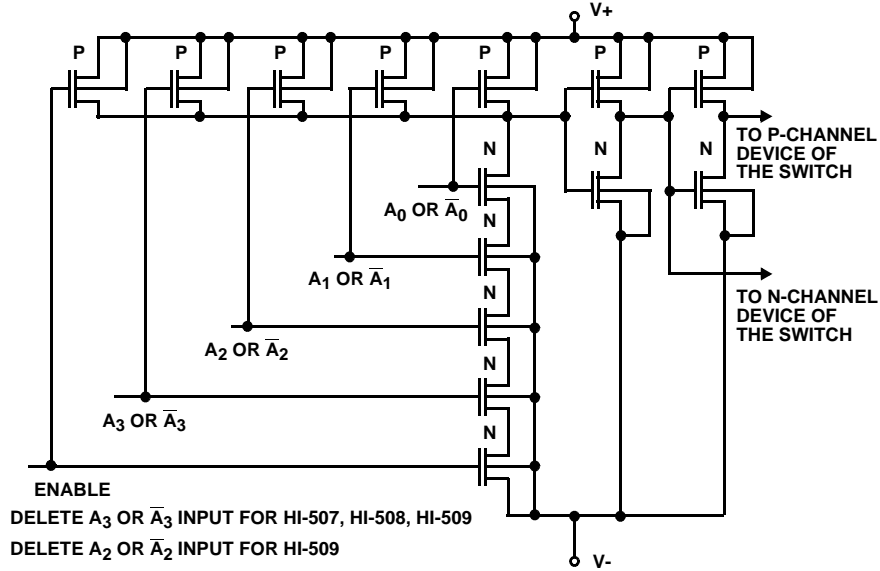


HI-509

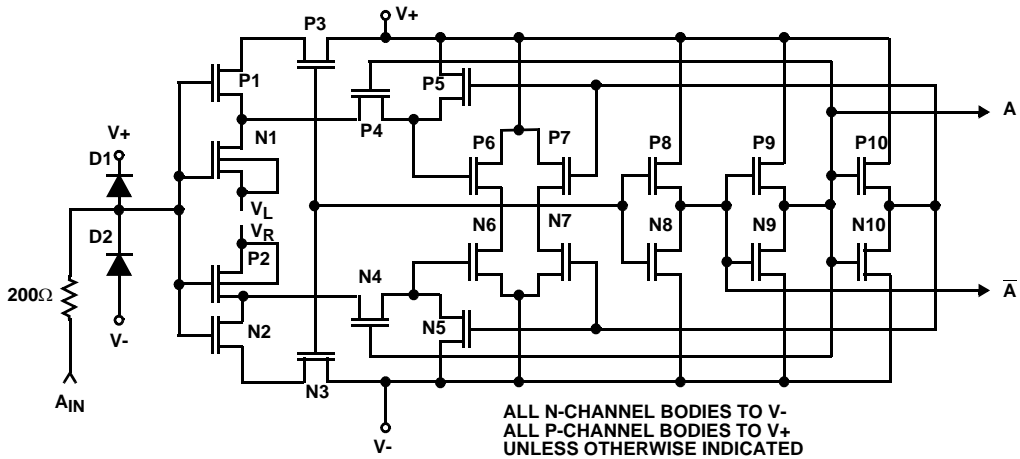


Schematic Diagrams

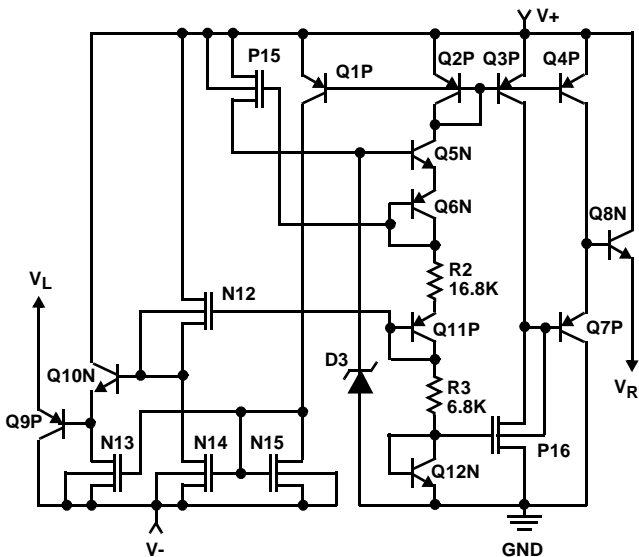
ADDRESS DECODER



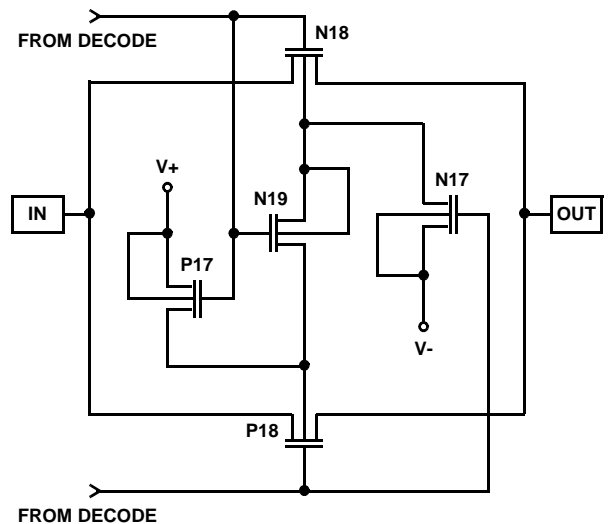
ADDRESS INPUT BUFFER LEVEL SHIFTER



TTL REFERENCE CIRCUIT



MULTIPLEX SWITCH



# HI-506, HI-507, HI-508, HI-509

## Absolute Maximum Ratings

|   |      |
|---|------|
| V+ to V- . . . . .  | +44V |
| V+ to GND . . . . .   | +22V |
| V- to GND . . . . .   | -25V |
| Digital Input Voltage (V <sub>EN</sub> , V <sub>A</sub> ) . . . . . (V-) -4V to (V+) +4V or 20mA,<br>Whichever Occurs First |      |
| Analog Signal (V <sub>IN</sub> , V <sub>OUT</sub> , Note 2) . . . . . (V-) -2V to (V+) +2V                                  |      |
| Continuous Current, In or Out . . . . .   | 20mA |
| Peak Current, In or Out (Pulsed 1ms, 10% Duty Cycle Max) .  | 40mA |

## Operating Conditions

|   |                    |
|---|--------------------|
| Temperature Ranges                      |                    |
| HI-506/507/508/509-2 . . . . .          | -55°C to 125°C     |
| HI-506/508/509-4 . . . . .              | -25°C to 85°C      |
| HI-506/507/508/509-5 . . . . .          | 0°C to 75°C        |
| HI-506/508-9 . . . . .                  | -40°C to 85°C      |
| Typical Minimum Supply Voltage. . . . . | ±10V or Single 20V |

## Thermal Information

|  |                                  |                      |
|--|----------------------------------|----------------------|
| Thermal Resistance (Typical, Note 1)               | $\theta_{JA}$ (°C/W)             | $\theta_{JC}$ (°C/W) |
| 16 Ld CERDIP Package. . . . .                      | 85                               | 32                   |
| 16 Ld SOIC Package . . . . .                       | 115                              | N/A                  |
| 16 Ld PDIP Package . . . . .                       | 100                              | N/A                  |
| 20 Ld PLCC Package. . . . .                        | 80                               | N/A                  |
| 28 Ld CERDIP Package. . . . .                      | 55                               | 18                   |
| 28 Ld PDIP Package . . . . .                       | 60                               | N/A                  |
| 28 Ld SOIC Package . . . . .                       | 70                               | N/A                  |
| 28 Ld PLCC Package. . . . .                        | 70                               | N/A                  |
| Maximum Junction Temperature                       |                                  |                      |
| Ceramic Packages . . . . .                         | 175°C                            |                      |
| Plastic Packages . . . . .                         | 150°C                            |                      |
| Maximum Storage Temperature Range . . . . .        | -65°C to 150°C                   |                      |
| Maximum Lead Temperature (Soldering 10s) . . . . . | 300°C                            |                      |
|  | (SOIC and PLCC - Lead Tips Only) |                      |

**CAUTION:** Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### NOTE:

- $\theta_{JA}$  is measured with the component mounted on a low effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
- Signals on IN or OUT exceeding V+ or V- are clamped by internal diodes. Limit resulting current to maximum current ratings. If an overvoltage condition is anticipated (analog input exceeds either power supply voltage), the Intersil HI-546/HI-547/HI-548/HI-549 multiplexers are recommended.

**Electrical Specifications** Supplies = +15V, -15V; V<sub>AH</sub> (Logic Level High) = 2.4V; V<sub>AL</sub> (Logic Level Low) = 0.8V, Unless Otherwise Specified. For Test Conditions, Consult Test Circuits Section

| PARAMETER  | TEST CONDITIONS | TEMP (°C) | -2  |      |      | -4, -5, -9 |      |      | UNITS |
|--|-----------------|-----------|-----|------|------|------------|------|------|-------|
|  |                 |           | MIN | TYP  | MAX  | MIN        | TYP  | MAX  |       |
| <b>DYNAMIC CHARACTERISTICS</b>                         |                 |           |     |      |      |            |      |      |       |
| Access Time, t <sub>A</sub>                            |                 | 25        | -   | 250  | 500  | -          | 250  | -    | ns    |
|  |                 | Full      | -   | -    | 1000 | -          | -    | 1000 | ns    |
| Break-Before-Make Delay, t <sub>OPEN</sub>             |                 | 25        | 25  | 80   | -    | 25         | 80   | -    | ns    |
| Enable Delay (ON), t <sub>ON(EN)</sub>                 |                 | 25        | -   | 250  | 500  | -          | 250  | -    | ns    |
|  |                 | Full      | -   | -    | 1000 | -          | -    | 1000 | ns    |
| Enable Delay (OFF), t <sub>OFF(EN)</sub>               |                 | 25        | -   | 250  | 500  | -          | 250  | -    | ns    |
|  |                 | Full      | -   | -    | 1000 | -          | -    | 1000 | ns    |
| Settling Time, t <sub>S</sub><br>(HI-506 and HI-507)   | To 0.1%         | 25        | -   | 1.2  | -    | -          | 1.2  | -    | μs    |
|  | To 0.01%        | 25        | -   | 2.4  | -    | -          | 2.4  | -    | μs    |
| Settling Time, t <sub>S</sub><br>(HI-508 and HI-509)   | To 0.1%         | 25        | -   | 360  | -    | -          | 360  | -    | ns    |
|  | To 0.01%        | 25        | -   | 600  | -    | -          | 600  | -    | ns    |
| Off Isolation  | Note 6          | 25        | 50  | 68   | -    | 50         | 68   | -    | dB    |
| Channel Input Capacitance, C <sub>S(OFF)</sub>         |                 | 25        | -   | 10   | -    | -          | 10   | -    | pF    |
| Channel Output Capacitance, C <sub>D(OFF)</sub>        | HI-506          | 25        | -   | 52   | -    | -          | 52   | -    | pF    |
|  | HI-507          | 25        | -   | 30   | -    | -          | 30   | -    | pF    |
|  | HI-508          | 25        | -   | 17   | -    | -          | 17   | -    | pF    |
|  | HI-509          | 25        | -   | 12   | -    | -          | 12   | -    | pF    |
| Digital Input Capacitance, C <sub>A</sub>              |                 | 25        | -   | 6    | -    | -          | 6    | -    | pF    |
| Input to Output Capacitance, C <sub>DS(OFF)</sub>      |                 | 25        | -   | 0.08 | -    | -          | 0.08 | -    | pF    |
| <b>DIGITAL INPUT CHARACTERISTICS</b>                   |                 |           |     |      |      |            |      |      |       |
| Input Low Threshold, V <sub>AL</sub>                   |                 | Full      | -   | -    | 0.8  | -          | -    | 0.8  | V     |
| Input High Threshold, V <sub>AH</sub>                  |                 | Full      | 2.4 | -    | -    | 2.4        | -    | -    | V     |
| Input Leakage Current<br>(High or Low), I <sub>A</sub> | Note 5          | Full      | -   | -    | 1.0  | -          | -    | 1.0  | μA    |

# HI-506, HI-507, HI-508, HI-509

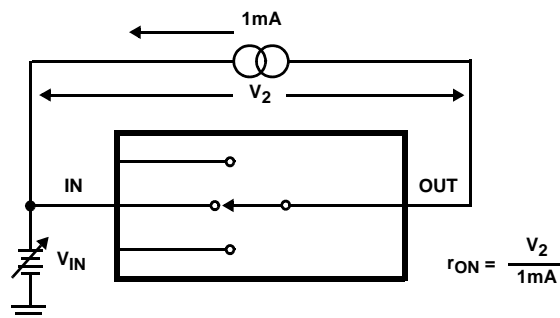
**Electrical Specifications** Supplies = +15V, -15V;  $V_{AH}$  (Logic Level High) = 2.4V;  $V_{AL}$  (Logic Level Low) = 0.8V, Unless Otherwise Specified. For Test Conditions, Consult Test Circuits Section **(Continued)**

| PARAMETER  | TEST CONDITIONS | TEMP (°C) | -2  |      |     | -4, -5, -9 |      |     | UNITS    |
|--|-----------------|-----------|-----|------|-----|------------|------|-----|----------|
|  |                 |           | MIN | TYP  | MAX | MIN        | TYP  | MAX |          |
| <b>ANALOG CHANNEL CHARACTERISTICS</b>  |                 |           |     |      |     |            |      |     |          |
| Analog Signal Range, $V_{IN}$  |                 | Full      | -15 | -    | +15 | -15        | -    | +15 | V        |
| On Resistance, $r_{ON}$  | Note 3          | 25        | -   | 180  | 300 | -          | 180  | 400 | $\Omega$ |
| $\Delta r_{ON}$ , (Any Two Channels)   |                 | 25        | -   | 5    | -   | -          | 5    | -   | %        |
| Off Input Leakage Current, $I_{S(OFF)}$                                      | Note 4          | 25        | -   | 0.03 | -   | -          | 0.03 | -   | nA       |
|  |                 | Full      | -   | -    | 50  | -          | -    | 50  | nA       |
| Off Output Leakage Current, $I_{D(OFF)}$                                     | Note 4          | 25        | -   | 0.3  | -   | -          | 0.3  | -   | nA       |
| HI-506   |                 | Full      | -   | -    | 300 | -          | -    | 300 | nA       |
| HI-507   |                 | Full      | -   | -    | 200 | -          | -    | 200 | nA       |
| HI-508   |                 | Full      | -   | -    | 200 | -          | -    | 200 | nA       |
| HI-509   |                 | Full      | -   | -    | 100 | -          | -    | 100 | nA       |
| On Channel Leakage Current, $I_{D(ON)}$                                      | Note 4          | 25        | -   | 0.3  | -   | -          | 0.3  | -   | nA       |
| HI-506   |                 | Full      | -   | -    | 300 | -          | -    | 300 | nA       |
| HI-507   |                 | Full      | -   | -    | 200 | -          | -    | 200 | nA       |
| HI-508   |                 | Full      | -   | -    | 200 | -          | -    | 200 | nA       |
| HI-509   |                 | Full      | -   | -    | 100 | -          | -    | 100 | nA       |
| Differential Off Output Leakage Current, $I_{DIFF}$<br>(HI-507, HI-509 Only) |                 | Full      | -   | -    | 50  | -          | -    | 50  | nA       |
| <b>POWER SUPPLY CHARACTERISTICS</b>  |                 |           |     |      |     |            |      |     |          |
| Current, $I_+$   |                 |           |     |      |     |            |      |     |          |
| HI-506/HI-507  | Note 7          | Full      | -   | 1.5  | 3.0 | -          | 1.5  | 3.0 | mA       |
| HI-508/HI-509  | Note 7          | Full      | -   | 1.5  | 2.4 | -          | 1.5  | 2.4 | mA       |
| Current, $I_-$   |                 |           |     |      |     |            |      |     |          |
| HI-506/HI-507  | Note 7          | Full      | -   | 0.4  | 1.0 | -          | 0.4  | 1.0 | mA       |
| HI-508/HI-509  | Note 7          | Full      | -   | 0.4  | 1.0 | -          | 0.4  | 1.0 | mA       |
| Power Dissipation, $P_D$   |                 |           |     |      |     |            |      |     |          |
| HI-506/HI-507  |                 | Full      | -   | -    | 60  | -          | -    | 60  | mW       |
| HI-508/HI-509  |                 | Full      | -   | -    | 51  | -          | -    | 51  | mW       |

**NOTES:**

3.  $V_{OUT} = \pm 10V$ ,  $I_{OUT} = \bar{\pm} 1mA$ .
4. 10nA is the practical lower limit for high speed measurement in the production test environment.
5. Digital input leakage is primarily due to the clamp diodes (see Schematic). Typical leakage is less than 1nA at 25°C.
6.  $V_{EN} = 0.8V$ ,  $R_L = 1K$ ,  $C_L = 15pF$ ,  $V_S = 7V_{RMS}$ ,  $f = 100kHz$ .
7.  $V_{EN}$ ,  $V_A = 0V$  or 2.4V.

**Test Circuits and Waveforms**  $T_A = 25^\circ C$ ,  $V_{SUPPLY} = \pm 15V$ ,  $V_{AH} = 2.4V$ ,  $V_{AL} = 0.8V$ , Unless Otherwise Specified



**FIGURE 1A. TEST CIRCUIT**

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified (Continued)

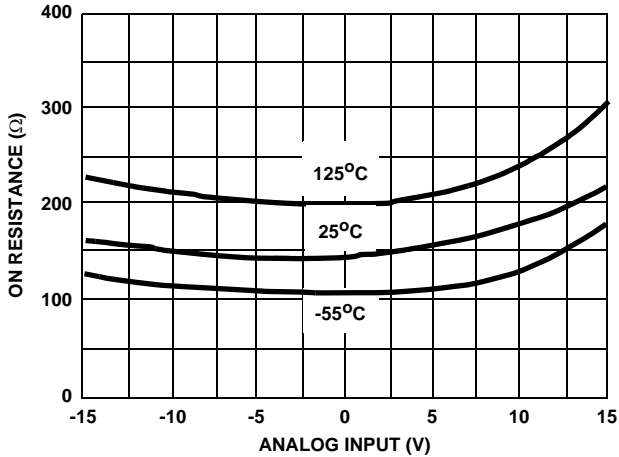


FIGURE 1B. ON RESISTANCE vs ANALOG INPUT VOLTAGE

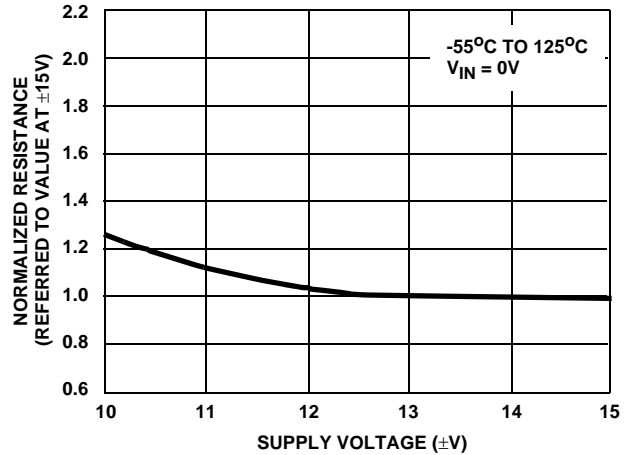


FIGURE 1C. NORMALIZED ON RESISTANCE vs SUPPLY VOLTAGE

FIGURE 1. ON RESISTANCE

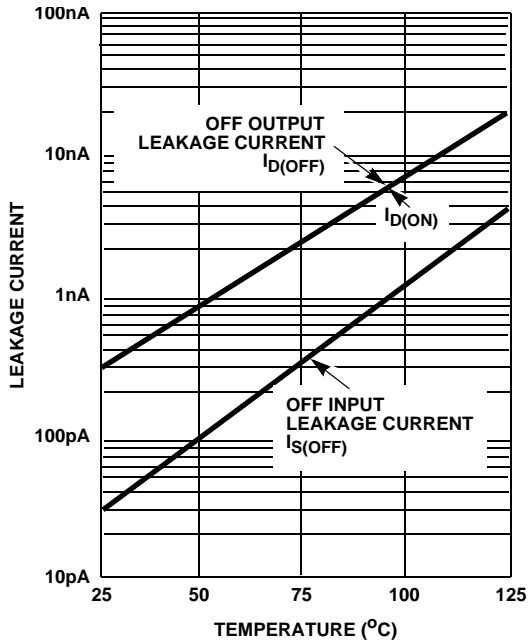


FIGURE 2A. LEAKAGE CURRENT vs TEMPERATURE

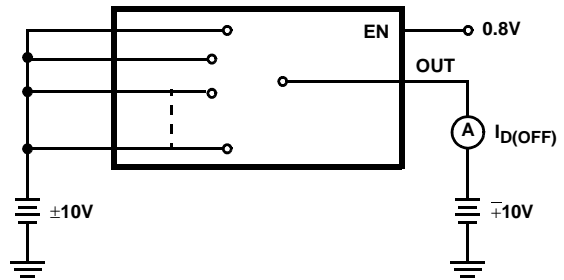


FIGURE 2B.  $I_{\text{D(OFF)}}$  TEST CIRCUIT (NOTE 8)

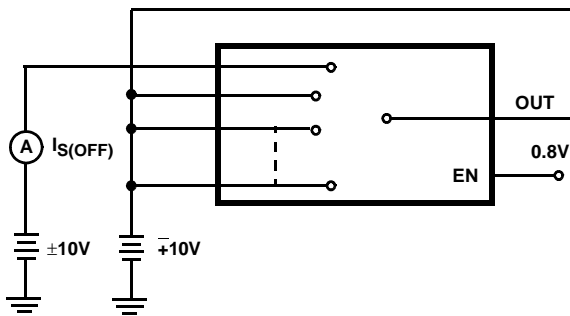


FIGURE 2C.  $I_{\text{S(OFF)}}$  TEST CIRCUIT (NOTE 8)

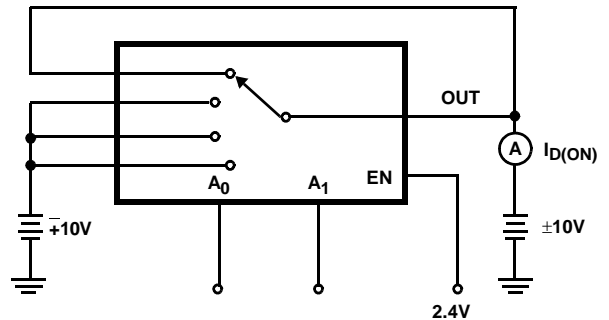


FIGURE 2D.  $I_{\text{D(ON)}}$  TEST CIRCUIT (NOTE 8)

FIGURE 2. LEAKAGE CURRENTS

NOTE:

8. Two measurements per channel:  $\pm 10\text{V}$  and  $\mp 10\text{V}$ . (Two measurements per device for  $I_{\text{D(OFF)}}$   $\pm 10\text{V}$  and  $\mp 10\text{V}$ )

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified (Continued)

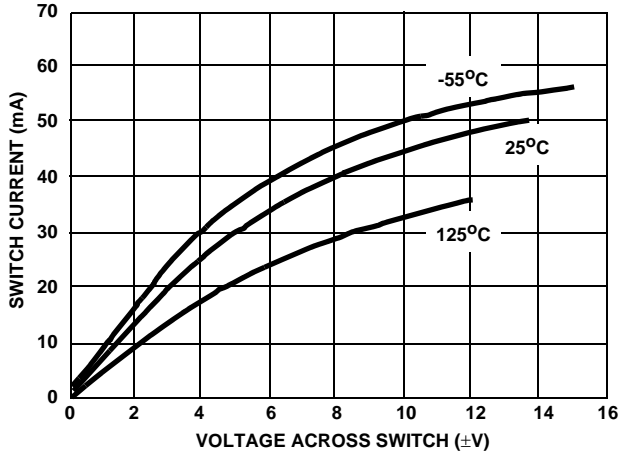


FIGURE 3A. ON CHANNEL CURRENT vs VOLTAGE

FIGURE 3. ON CHANNEL CURRENT

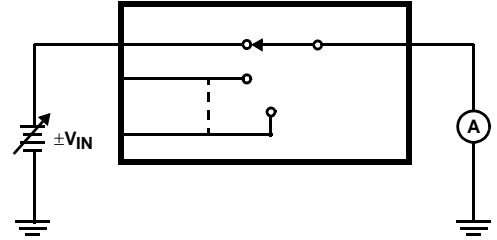


FIGURE 3B. TEST CIRCUIT

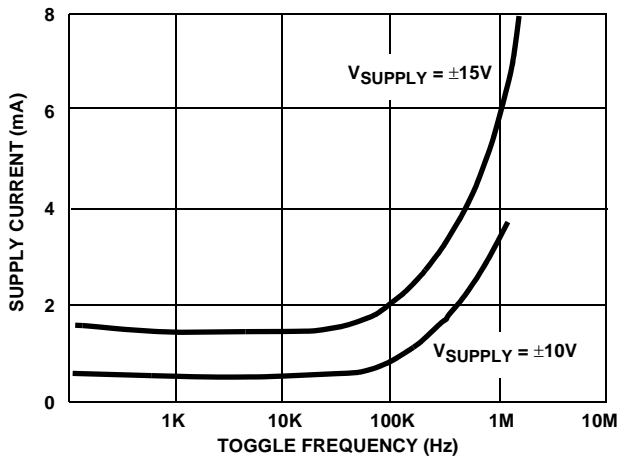


FIGURE 4A. SUPPLY CURRENT vs TOGGLE FREQUENCY

FIGURE 4. DYNAMIC SUPPLY CURRENT

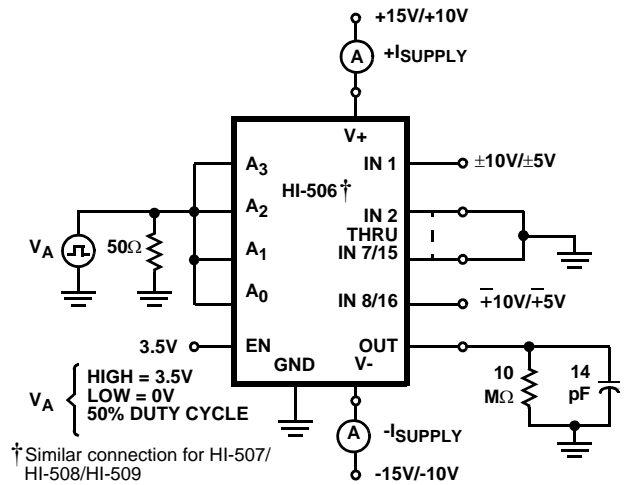


FIGURE 4B. TEST CIRCUIT

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified (Continued)

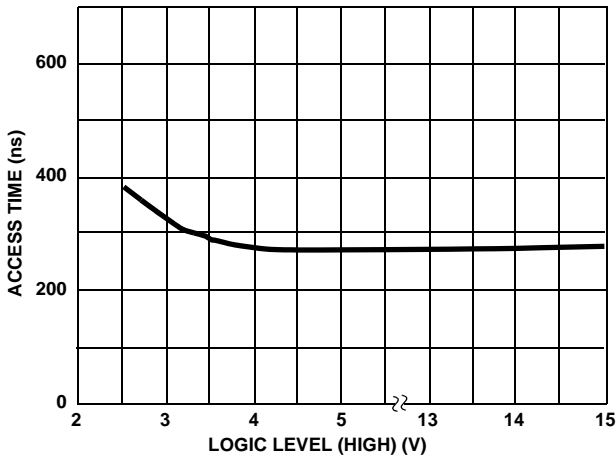


FIGURE 5A. ACCESS TIME vs LOGIC LEVEL (HIGH)

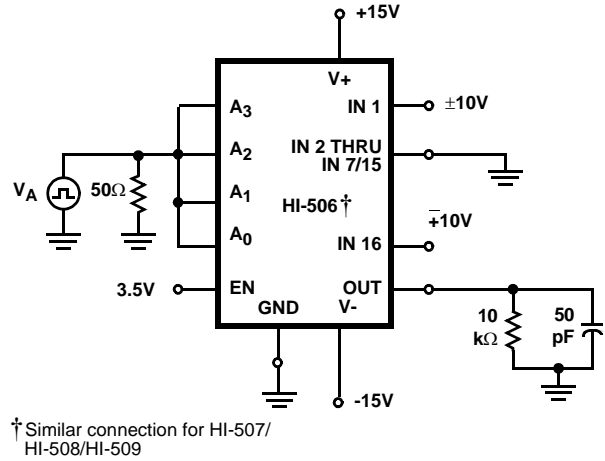


FIGURE 5B. TEST CIRCUIT

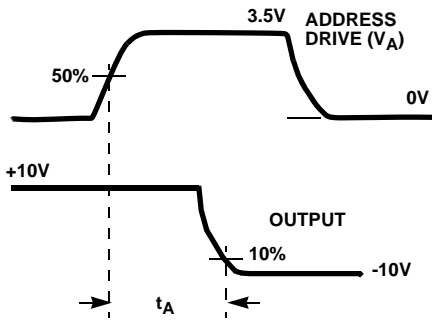


FIGURE 5C. MEASUREMENT POINTS

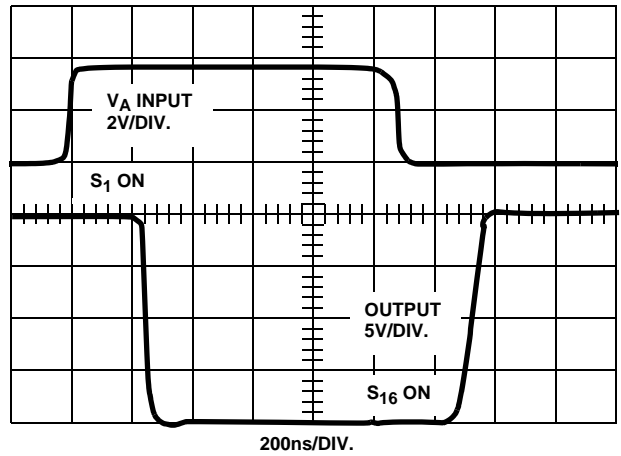


FIGURE 5D. WAVEFORMS

FIGURE 5. ACCESS TIME

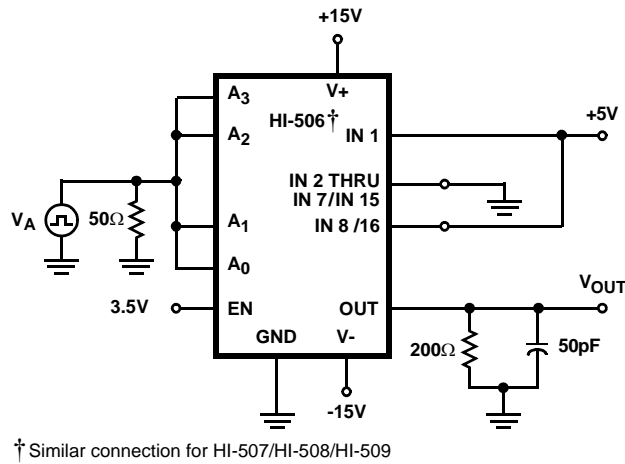


FIGURE 6A. TEST CIRCUIT

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified (Continued)

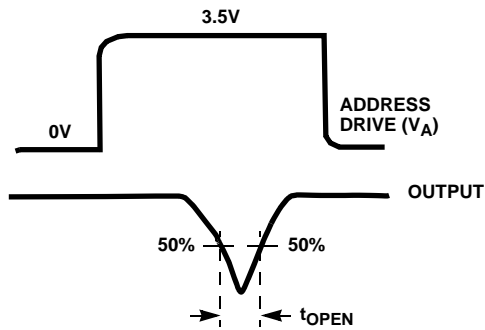


FIGURE 6B. MEASUREMENT POINTS

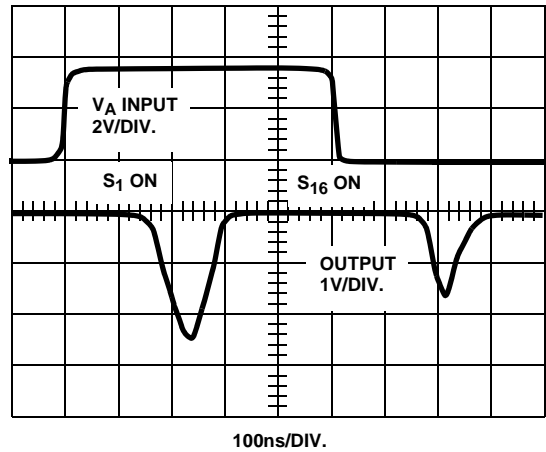


FIGURE 6C. WAVEFORMS

FIGURE 6. BREAK-BEFORE-MAKE DELAY

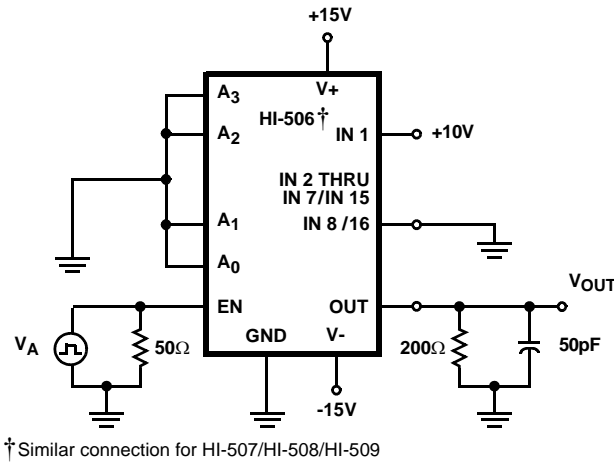


FIGURE 7A. TEST CIRCUIT

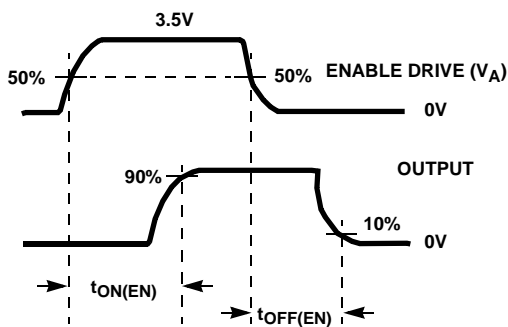


FIGURE 7B. MEASUREMENT POINTS

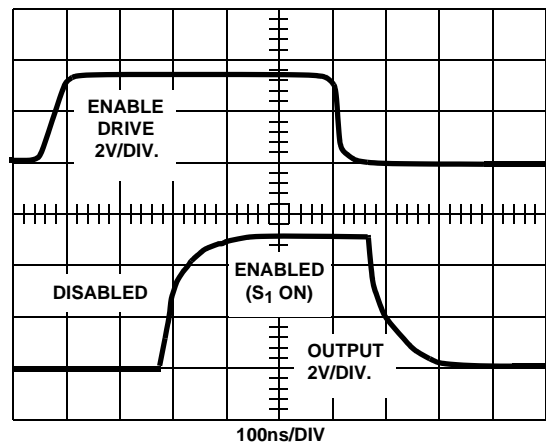


FIGURE 7C. WAVEFORMS

FIGURE 7. ENABLE DELAYS

**Typical Performance Curves**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 2.4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ , Unless Otherwise Specified

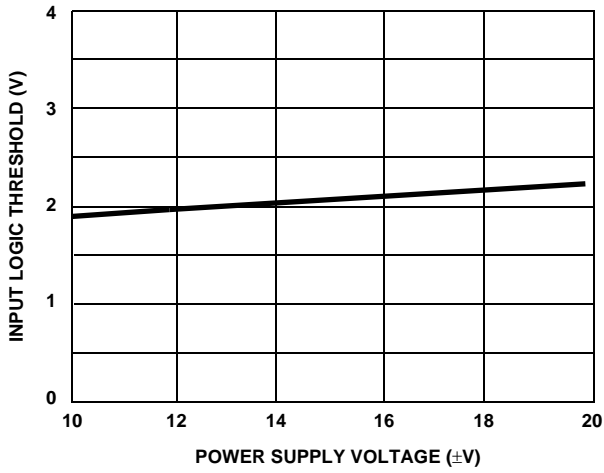


FIGURE 8. LOGIC THRESHOLD vs POWER SUPPLY VOLTAGE

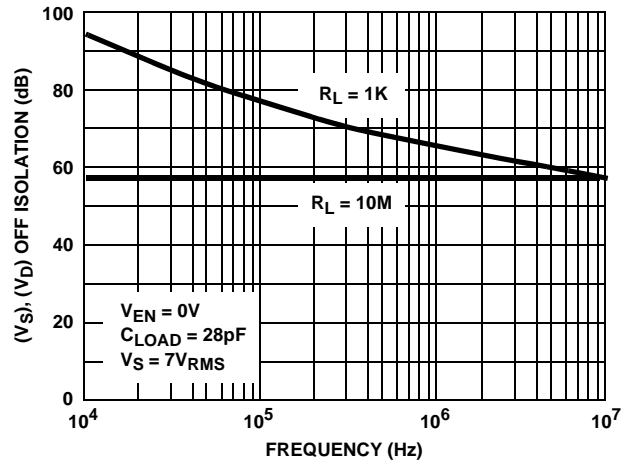


FIGURE 9. OFF ISOLATION vs FREQUENCY

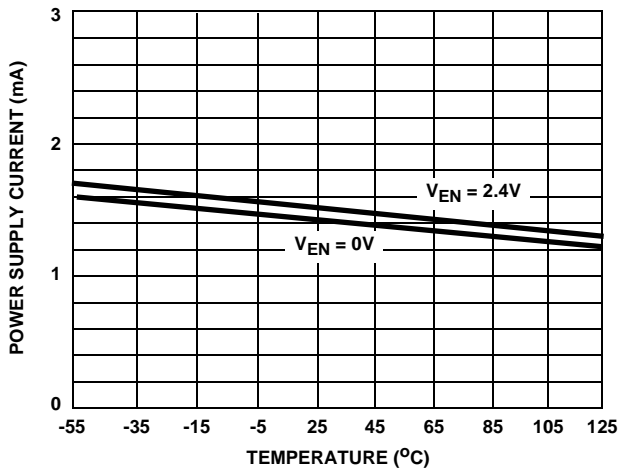


FIGURE 10A. HI-506/HI-507

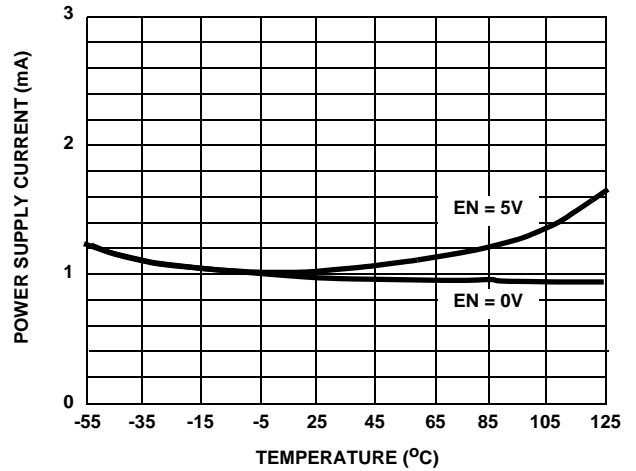


FIGURE 10B. HI-508/HI-509

FIGURE 10. POWER SUPPLY CURRENT vs TEMPERATURE

**Die Characteristics**

**DIE DIMENSIONS:**

129 mils x 82 mils

**METALLIZATION:**

Type: CuAl

Thickness:  $16\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

**SUBSTRATE POTENTIAL (NOTE):**

$-V_{\text{SUPPLY}}$

**PASSIVATION:**

Type: Nitride/Silox

Nitride Thickness:  $3.5\text{k}\text{\AA} \pm 1\text{k}\text{\AA}$

Silox Thickness:  $12\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

**WORST CASE CURRENT DENSITY:**

$1.4 \times 10^5 \text{ A/cm}^2$

**TRANSISTOR COUNT:**

421

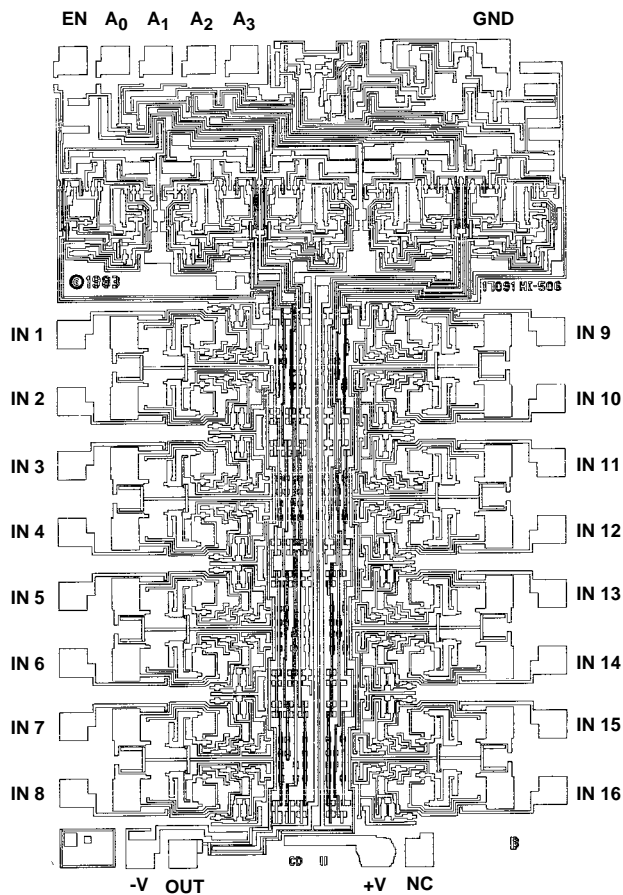
**PROCESS:**

CMOS-DI

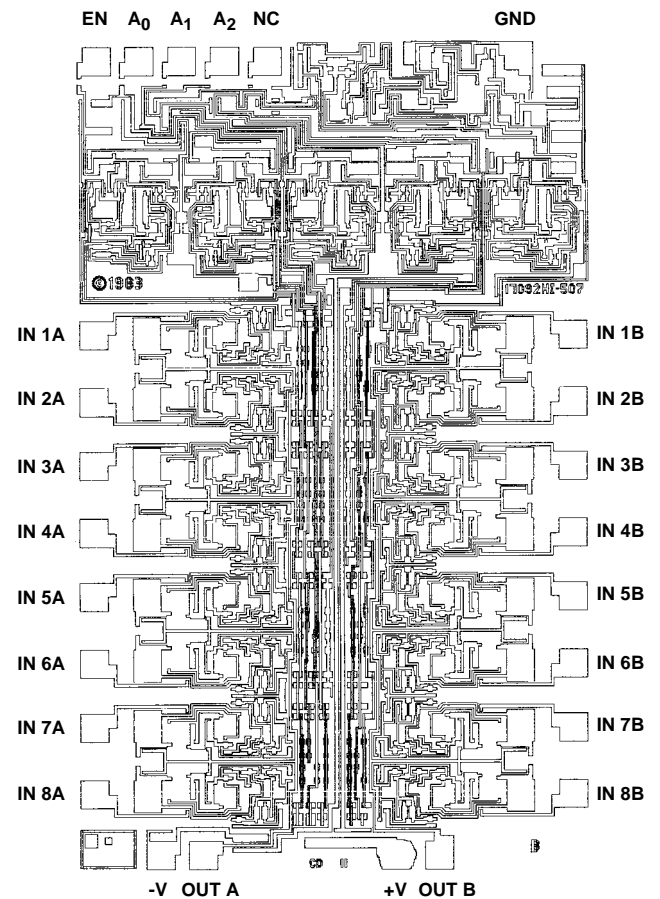
NOTE: The substrate appears resistive to the  $-V_{\text{SUPPLY}}$  terminal, therefore it may be left floating (Insulating Die Mount) or it may be mounted on a conductor at  $-V_{\text{SUPPLY}}$  potential.

**Metallization Mask Layout**

HI-506



HI-507



**Die Characteristics**

**DIE DIMENSIONS:**

81.9 mils x 90.2 mils

**METALLIZATION:**

Type: CuAl

Thickness:  $16\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

**SUBSTRATE POTENTIAL (NOTE):**

$-V_{\text{SUPPLY}}$

**PASSIVATION:**

Type: Nitride/Silox

Nitride Thickness:  $3.5\text{k}\text{\AA} \pm 1\text{k}\text{\AA}$

Silox Thickness:  $12\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

**WORST CASE CURRENT DENSITY:**

$1.4 \times 10^5 \text{ A/cm}^2$

**TRANSISTOR COUNT:**

234

**PROCESS:**

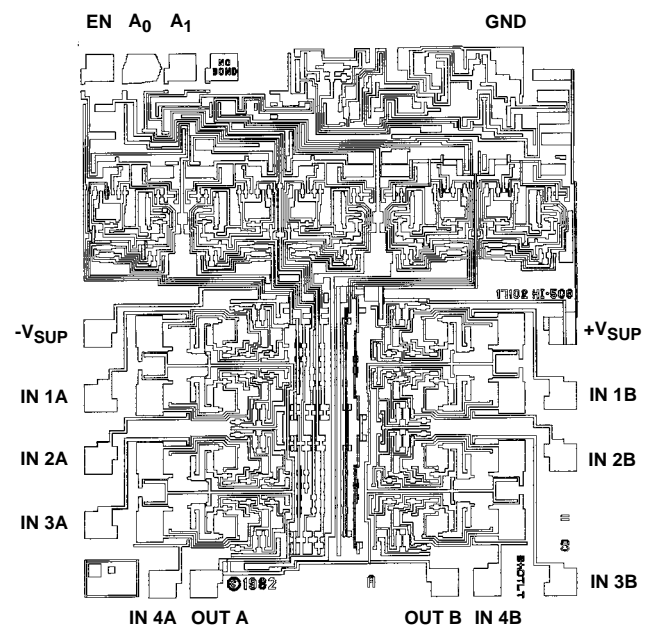
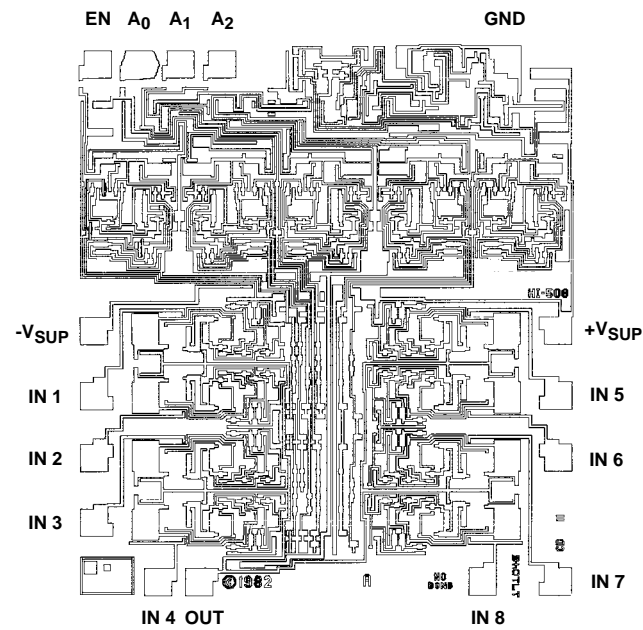
CMOS-DI

NOTE: The substrate appears resistive to the  $-V_{\text{SUPPLY}}$  terminal, therefore it may be left floating (Insulating Die Mount) or it may be mounted on a conductor at  $-V_{\text{SUPPLY}}$  potential.

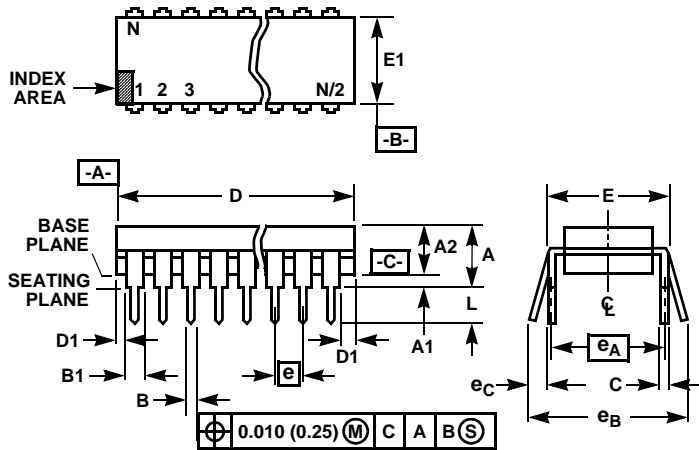
**Metallization Mask Layout**

HI-508

HI-509



Dual-In-Line Plastic Packages (PDIP)



NOTES:

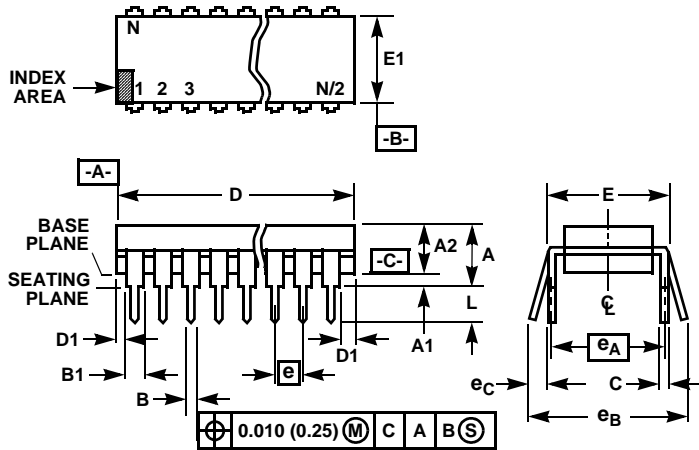
- Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
- Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
- Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
- D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
- E and  $e_A$  are measured with the leads constrained to be perpendicular to datum -C-.
- $e_B$  and  $e_C$  are measured at the lead tips with the leads unconstrained.  $e_C$  must be zero or greater.
- B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
- N is the maximum number of terminal positions.
- Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

E16.3 (JEDEC MS-001-BB ISSUE D)  
16 LEAD DUAL-IN-LINE PLASTIC PACKAGE

| SYMBOL | INCHES    |       | MILLIMETERS |       | NOTES |
|--------|-----------|-------|-------------|-------|-------|
|        | MIN       | MAX   | MIN         | MAX   |       |
| A      | -         | 0.210 | -           | 5.33  | 4     |
| A1     | 0.015     | -     | 0.39        | -     | 4     |
| A2     | 0.115     | 0.195 | 2.93        | 4.95  | -     |
| B      | 0.014     | 0.022 | 0.356       | 0.558 | -     |
| B1     | 0.045     | 0.070 | 1.15        | 1.77  | 8, 10 |
| C      | 0.008     | 0.014 | 0.204       | 0.355 | -     |
| D      | 0.735     | 0.775 | 18.66       | 19.68 | 5     |
| D1     | 0.005     | -     | 0.13        | -     | 5     |
| E      | 0.300     | 0.325 | 7.62        | 8.25  | 6     |
| E1     | 0.240     | 0.280 | 6.10        | 7.11  | 5     |
| e      | 0.100 BSC |       | 2.54 BSC    |       | -     |
| $e_A$  | 0.300 BSC |       | 7.62 BSC    |       | 6     |
| $e_B$  | -         | 0.430 | -           | 10.92 | 7     |
| L      | 0.115     | 0.150 | 2.93        | 3.81  | 4     |
| N      | 16        |       | 16          |       | 9     |

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Dual-In-Line Plastic Packages (PDIP)



NOTES:

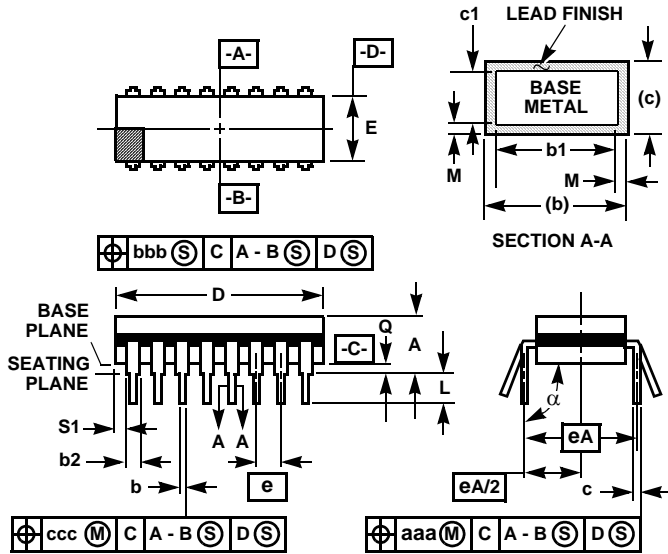
1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
4. Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
5. D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
6. E and  $e_A$  are measured with the leads constrained to be perpendicular to datum  $-C-$ .
7.  $e_B$  and  $e_C$  are measured at the lead tips with the leads unconstrained.  $e_C$  must be zero or greater.
8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
9. N is the maximum number of terminal positions.
10. Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

E28.6 (JEDEC MS-011-AB ISSUE B)  
28 LEAD DUAL-IN-LINE PLASTIC PACKAGE

| SYMBOL | INCHES    |       | MILLIMETERS |       | NOTES |
|--------|-----------|-------|-------------|-------|-------|
|        | MIN       | MAX   | MIN         | MAX   |       |
| A      | -         | 0.250 | -           | 6.35  | 4     |
| A1     | 0.015     | -     | 0.39        | -     | 4     |
| A2     | 0.125     | 0.195 | 3.18        | 4.95  | -     |
| B      | 0.014     | 0.022 | 0.356       | 0.558 | -     |
| B1     | 0.030     | 0.070 | 0.77        | 1.77  | 8     |
| C      | 0.008     | 0.015 | 0.204       | 0.381 | -     |
| D      | 1.380     | 1.565 | 35.1        | 39.7  | 5     |
| D1     | 0.005     | -     | 0.13        | -     | 5     |
| E      | 0.600     | 0.625 | 15.24       | 15.87 | 6     |
| E1     | 0.485     | 0.580 | 12.32       | 14.73 | 5     |
| e      | 0.100 BSC |       | 2.54 BSC    |       | -     |
| $e_A$  | 0.600 BSC |       | 15.24 BSC   |       | 6     |
| $e_B$  | -         | 0.700 | -           | 17.78 | 7     |
| L      | 0.115     | 0.200 | 2.93        | 5.08  | 4     |
| N      | 28        |       | 28          |       | 9     |

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Ceramic Dual-In-Line Frit Seal Packages (CERDIP)



NOTES:

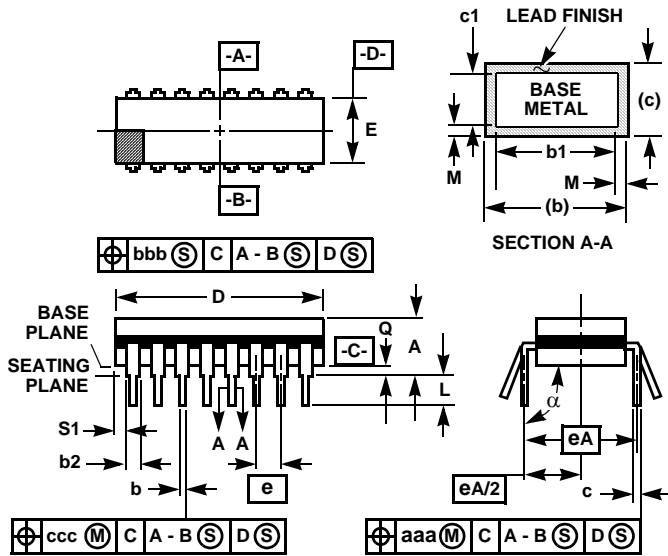
1. Index area: A notch or a pin one identification mark shall be located adjacent to pin one and shall be located within the shaded area shown. The manufacturer's identification shall not be used as a pin one identification mark.
2. The maximum limits of lead dimensions b and c or M shall be measured at the centroid of the finished lead surfaces, when solder dip or tin plate lead finish is applied.
3. Dimensions b1 and c1 apply to lead base metal only. Dimension M applies to lead plating and finish thickness.
4. Corner leads (1, N, N/2, and N/2+1) may be configured with a partial lead paddle. For this configuration dimension b3 replaces dimension b2.
5. This dimension allows for off-center lid, meniscus, and glass overrun.
6. Dimension Q shall be measured from the seating plane to the base plane.
7. Measure dimension S1 at all four corners.
8. N is the maximum number of terminal positions.
9. Dimensioning and tolerancing per ANSI Y14.5M - 1982.
10. Controlling dimension: INCH.

F16.3 MIL-STD-1835 GDIP1-T16 (D-2, CONFIGURATION A)  
16 LEAD CERAMIC DUAL-IN-LINE FRIT SEAL PACKAGE

| SYMBOL | INCHES    |        | MILLIMETERS |       | NOTES |
|--------|-----------|--------|-------------|-------|-------|
|        | MIN       | MAX    | MIN         | MAX   |       |
| A      | -         | 0.200  | -           | 5.08  | -     |
| b      | 0.014     | 0.026  | 0.36        | 0.66  | 2     |
| b1     | 0.014     | 0.023  | 0.36        | 0.58  | 3     |
| b2     | 0.045     | 0.065  | 1.14        | 1.65  | -     |
| b3     | 0.023     | 0.045  | 0.58        | 1.14  | 4     |
| c      | 0.008     | 0.018  | 0.20        | 0.46  | 2     |
| c1     | 0.008     | 0.015  | 0.20        | 0.38  | 3     |
| D      | -         | 0.840  | -           | 21.34 | 5     |
| E      | 0.220     | 0.310  | 5.59        | 7.87  | 5     |
| e      | 0.100 BSC |        | 2.54 BSC    |       | -     |
| eA     | 0.300 BSC |        | 7.62 BSC    |       | -     |
| eA/2   | 0.150 BSC |        | 3.81 BSC    |       | -     |
| L      | 0.125     | 0.200  | 3.18        | 5.08  | -     |
| Q      | 0.015     | 0.060  | 0.38        | 1.52  | 6     |
| S1     | 0.005     | -      | 0.13        | -     | 7     |
| alpha  | 90°       | 105°   | 90°         | 105°  | -     |
| aaa    | -         | 0.015  | -           | 0.38  | -     |
| bbb    | -         | 0.030  | -           | 0.76  | -     |
| ccc    | -         | 0.010  | -           | 0.25  | -     |
| M      | -         | 0.0015 | -           | 0.038 | 2, 3  |
| N      | 16        |        | 16          |       | 8     |

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Ceramic Dual-In-Line Frit Seal Packages (CERDIP)



NOTES:

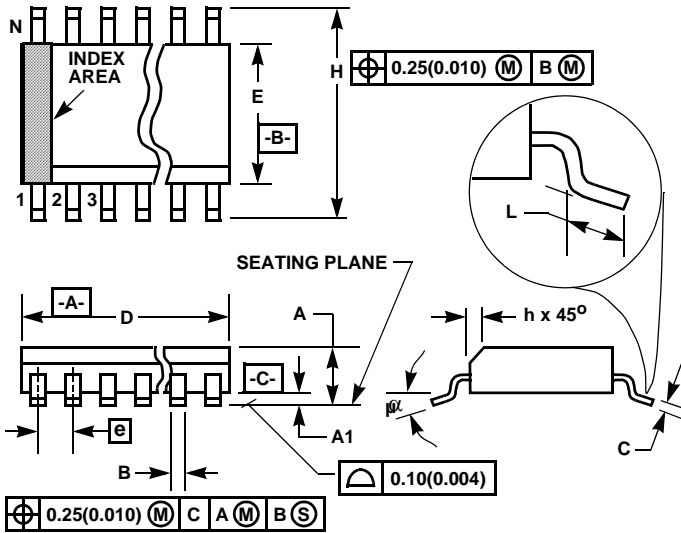
1. Index area: A notch or a pin one identification mark shall be located adjacent to pin one and shall be located within the shaded area shown. The manufacturer's identification shall not be used as a pin one identification mark.
2. The maximum limits of lead dimensions b and c or M shall be measured at the centroid of the finished lead surfaces, when solder dip or tin plate lead finish is applied.
3. Dimensions b1 and c1 apply to lead base metal only. Dimension M applies to lead plating and finish thickness.
4. Corner leads (1, N, N/2, and N/2+1) may be configured with a partial lead paddle. For this configuration dimension b3 replaces dimension b2.
5. This dimension allows for off-center lid, meniscus, and glass overrun.
6. Dimension Q shall be measured from the seating plane to the base plane.
7. Measure dimension S1 at all four corners.
8. N is the maximum number of terminal positions.
9. Dimensioning and tolerancing per ANSI Y14.5M - 1982.
10. Controlling dimension: INCH.

F28.6 MIL-STD-1835 GDIP1-T28 (D-10, CONFIGURATION A)  
28 LEAD CERAMIC DUAL-IN-LINE FRIT SEAL PACKAGE

| SYMBOL   | INCHES    |        | MILLIMETERS |       | NOTES |
|----------|-----------|--------|-------------|-------|-------|
|          | MIN       | MAX    | MIN         | MAX   |       |
| A        | -         | 0.232  | -           | 5.92  | -     |
| b        | 0.014     | 0.026  | 0.36        | 0.66  | 2     |
| b1       | 0.014     | 0.023  | 0.36        | 0.58  | 3     |
| b2       | 0.045     | 0.065  | 1.14        | 1.65  | -     |
| b3       | 0.023     | 0.045  | 0.58        | 1.14  | 4     |
| c        | 0.008     | 0.018  | 0.20        | 0.46  | 2     |
| c1       | 0.008     | 0.015  | 0.20        | 0.38  | 3     |
| D        | -         | 1.490  | -           | 37.85 | 5     |
| E        | 0.500     | 0.610  | 12.70       | 15.49 | 5     |
| e        | 0.100 BSC |        | 2.54 BSC    |       | -     |
| eA       | 0.600 BSC |        | 15.24 BSC   |       | -     |
| eA/2     | 0.300 BSC |        | 7.62 BSC    |       | -     |
| L        | 0.125     | 0.200  | 3.18        | 5.08  | -     |
| Q        | 0.015     | 0.060  | 0.38        | 1.52  | 6     |
| S1       | 0.005     | -      | 0.13        | -     | 7     |
| $\alpha$ | 90°       | 105°   | 90°         | 105°  | -     |
| aaa      | -         | 0.015  | -           | 0.38  | -     |
| bbb      | -         | 0.030  | -           | 0.76  | -     |
| ccc      | -         | 0.010  | -           | 0.25  | -     |
| M        | -         | 0.0015 | -           | 0.038 | 2, 3  |
| N        | 28        |        | 28          |       | 8     |

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**Small Outline Plastic Packages (SOIC)**



**M16.15** (JEDEC MS-012-AC ISSUE C)  
**16 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE**

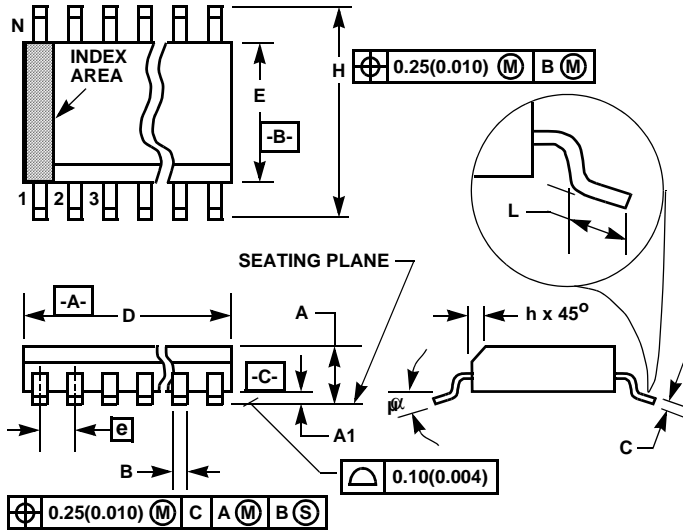
| SYMBOL   | INCHES    |        | MILLIMETERS |       | NOTES |
|----------|-----------|--------|-------------|-------|-------|
|          | MIN       | MAX    | MIN         | MAX   |       |
| A        | 0.0532    | 0.0688 | 1.35        | 1.75  | -     |
| A1       | 0.0040    | 0.0098 | 0.10        | 0.25  | -     |
| B        | 0.013     | 0.020  | 0.33        | 0.51  | 9     |
| C        | 0.0075    | 0.0098 | 0.19        | 0.25  | -     |
| D        | 0.3859    | 0.3937 | 9.80        | 10.00 | 3     |
| E        | 0.1497    | 0.1574 | 3.80        | 4.00  | 4     |
| e        | 0.050 BSC |        | 1.27 BSC    |       | -     |
| H        | 0.2284    | 0.2440 | 5.80        | 6.20  | -     |
| h        | 0.0099    | 0.0196 | 0.25        | 0.50  | 5     |
| L        | 0.016     | 0.050  | 0.40        | 1.27  | 6     |
| N        | 16        |        | 16          |       | 7     |
| $\alpha$ | 0°        | 8°     | 0°          | 8°    | -     |

**NOTES:**

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

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Small Outline Plastic Packages (SOIC)



**M28.3 (JEDEC MS-013-AE ISSUE C)**  
**28 LEAD WIDE BODY SMALL OUTLINE PLASTIC PACKAGE**

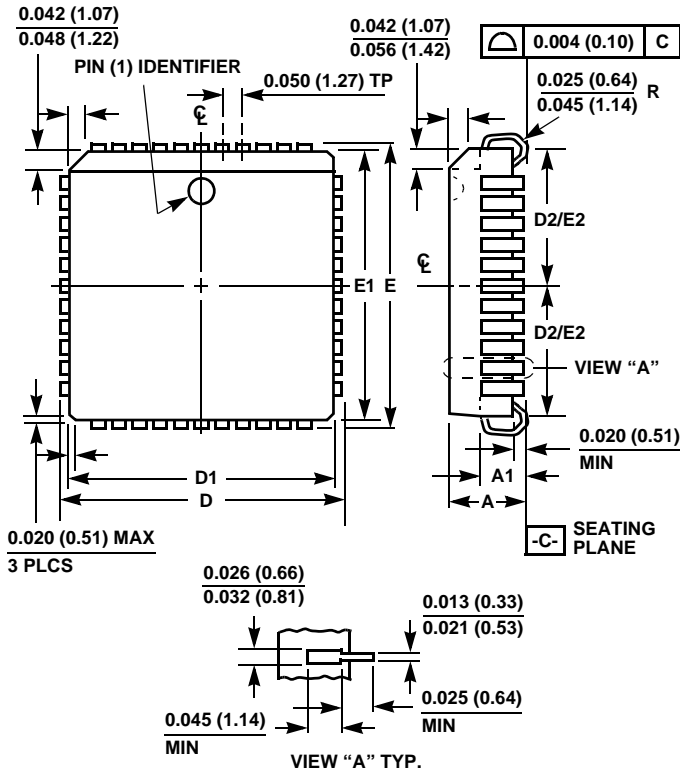
| SYMBOL   | INCHES   |        | MILLIMETERS |       | NOTES |
|----------|----------|--------|-------------|-------|-------|
|          | MIN      | MAX    | MIN         | MAX   |       |
| A        | 0.0926   | 0.1043 | 2.35        | 2.65  | -     |
| A1       | 0.0040   | 0.0118 | 0.10        | 0.30  | -     |
| B        | 0.013    | 0.0200 | 0.33        | 0.51  | 9     |
| C        | 0.0091   | 0.0125 | 0.23        | 0.32  | -     |
| D        | 0.6969   | 0.7125 | 17.70       | 18.10 | 3     |
| E        | 0.2914   | 0.2992 | 7.40        | 7.60  | 4     |
| e        | 0.05 BSC |        | 1.27 BSC    |       | -     |
| H        | 0.394    | 0.419  | 10.00       | 10.65 | -     |
| h        | 0.01     | 0.029  | 0.25        | 0.75  | 5     |
| L        | 0.016    | 0.050  | 0.40        | 1.27  | 6     |
| N        | 28       |        | 28          |       | 7     |
| $\alpha$ | 0°       | 8°     | 0°          | 8°    | -     |

NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch)
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

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Plastic Leaded Chip Carrier Packages (PLCC)



**N20.35 (JEDEC MS-018AA ISSUE A)**  
20 LEAD PLASTIC LEADED CHIP CARRIER PACKAGE

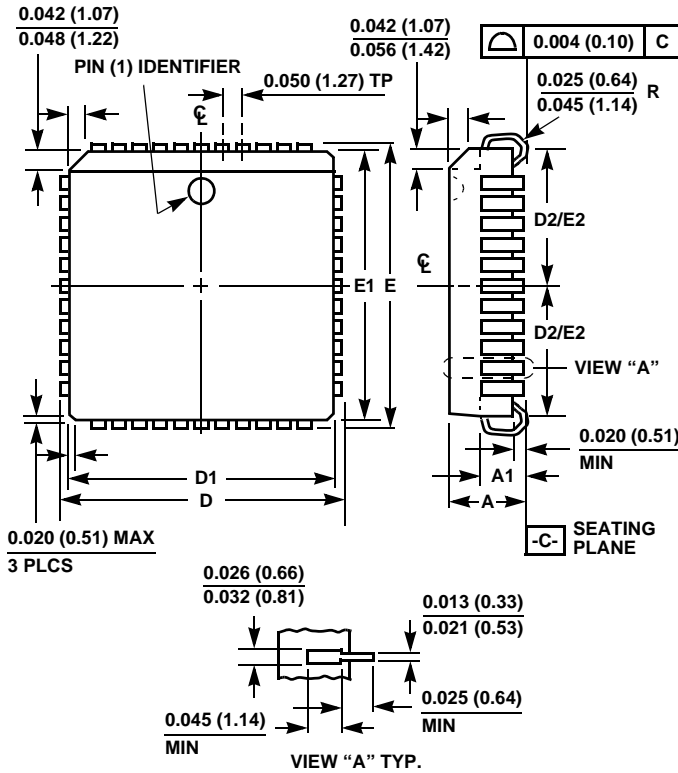
| SYMBOL | INCHES |       | MILLIMETERS |       | NOTES |
|--------|--------|-------|-------------|-------|-------|
|        | MIN    | MAX   | MIN         | MAX   |       |
| A      | 0.165  | 0.180 | 4.20        | 4.57  | -     |
| A1     | 0.090  | 0.120 | 2.29        | 3.04  | -     |
| D      | 0.385  | 0.395 | 9.78        | 10.03 | -     |
| D1     | 0.350  | 0.356 | 8.89        | 9.04  | 3     |
| D2     | 0.141  | 0.169 | 3.59        | 4.29  | 4, 5  |
| E      | 0.385  | 0.395 | 9.78        | 10.03 | -     |
| E1     | 0.350  | 0.356 | 8.89        | 9.04  | 3     |
| E2     | 0.141  | 0.169 | 3.59        | 4.29  | 4, 5  |
| N      | 20     |       | 20          |       | 6     |

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NOTES:

1. Controlling dimension: INCH. Converted millimeter dimensions are not necessarily exact.
2. Dimensions and tolerancing per ANSI Y14.5M-1982.
3. Dimensions D1 and E1 do not include mold protrusions. Allowable mold protrusion is 0.010 inch (0.25mm) per side. Dimensions D1 and E1 include mold mismatch and are measured at the extreme material condition at the body parting line.
4. To be measured at seating plane -C- contact point.
5. Centerline to be determined where center leads exit plastic body.
6. "N" is the number of terminal positions.

Plastic Leaded Chip Carrier Packages (PLCC)



N28.45 (JEDEC MS-018AB ISSUE A)  
28 LEAD PLASTIC LEADED CHIP CARRIER PACKAGE

| SYMBOL | INCHES |       | MILLIMETERS |       | NOTES |
|--------|--------|-------|-------------|-------|-------|
|        | MIN    | MAX   | MIN         | MAX   |       |
| A      | 0.165  | 0.180 | 4.20        | 4.57  | -     |
| A1     | 0.090  | 0.120 | 2.29        | 3.04  | -     |
| D      | 0.485  | 0.495 | 12.32       | 12.57 | -     |
| D1     | 0.450  | 0.456 | 11.43       | 11.58 | 3     |
| D2     | 0.191  | 0.219 | 4.86        | 5.56  | 4, 5  |
| E      | 0.485  | 0.495 | 12.32       | 12.57 | -     |
| E1     | 0.450  | 0.456 | 11.43       | 11.58 | 3     |
| E2     | 0.191  | 0.219 | 4.86        | 5.56  | 4, 5  |
| N      | 28     |       | 28          |       | 6     |

Rev. 2 11/97

NOTES:

- Controlling dimension: INCH. Converted millimeter dimensions are not necessarily exact.
- Dimensions and tolerancing per ANSI Y14.5M-1982.
- Dimensions D1 and E1 do not include mold protrusions. Allowable mold protrusion is 0.010 inch (0.25mm) per side. Dimensions D1 and E1 include mold mismatch and are measured at the extreme material condition at the body parting line.
- To be measured at seating plane -C- contact point.
- Centerline to be determined where center leads exit plastic body.
- "N" is the number of terminal positions.

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